

Search Notes

Application/Control No.

10/674,391

Examiner

Joseph L. Williams

Applicant(s)/Patent under
Reexamination

HANAI, TAKESHI

Art Unit

2879

SEARCHED

Class	Subclass	Date	Examiner
445	4 7	11/12/2005	JW

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
searched above class/sub		11/12/2005	JW

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
updated previous text seach	11/12/2005	JW